

Notice of References Cited		Application/Control No. 10/589,209	Applicant(s)/Patent Under Reexamination LARCHER ET AL.	
		Examiner JOHN A. HEVEY	Art Unit 1793	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,063,192 A	11-1991	Murakami et al.	502/303
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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